BUK9880-55A

N-channel TrenchMOS logic level FET

Rev. 02 — 12 April 2007

Product data sheet

1. Product profile

1.1 General description

N-channel enhancement mode power Field-Effect Transistor (FET) in a plastic package using NXP General Purpose Automotive (GPA) TrenchMOS technology.

1.2 Features

- Very low on-state resistance
- 150 °C rated

- Q101 compliant
- Logic level compatible

1.3 Applications

- Automotive systems
- Motors, lamps and solenoids
- General purpose power switching
- 12 V and 24 V loads

1.4 Quick reference data

- \blacksquare E_{DS(AL)S} \leq 36 mJ
- $I_D \le 7 A$

- \blacksquare R_{DSon} = 68 mΩ (typ)
- Arr P_{tot} \leq 8 W

2. Pinning information

Table 1. Pinning

Pin	Description	Simplified outline	Symbol
1	gate (G)		_
2	drain (D)	4	D
3	source (S)		
4	solder point; connected to drain (D)	1 -2 -3	
		SOT223 (SC-73)	mbb076 S



3. Ordering information

Table 2. Ordering information

Type number	Package		
	Name	Description	Version
BUK9880-55A	SC-73	plastic surface-mounted package with increased heatsink; 4 leads	SOT223

4. Limiting values

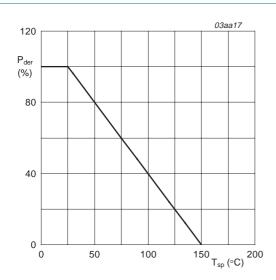
Table 3. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{DS}	drain-source voltage		-	55	V
V_{DGR}	drain-gate voltage (DC)	$R_{GS} = 20 \text{ k}\Omega$	-	55	V
V_{GS}	gate-source voltage		-	±15	V
I_D	drain current	$T_{sp} = 25 ^{\circ}\text{C}$; $V_{GS} = 5 \text{V}$; see Figure 2 and 3	-	7	Α
		T _{sp} = 100 °C; V _{GS} = 5 V; see <u>Figure 2</u>	-	4	Α
I _{DM}	peak drain current	T_{sp} = 25 °C; pulsed; $t_p \le 10 \mu s$; see Figure 3	-	30	Α
P _{tot}	total power dissipation	T _{sp} = 25 °C; see <u>Figure 1</u>	-	8	W
T _{stg}	storage temperature		-55	+150	°C
T _j	junction temperature		-55	+150	°C
Source-c	Irain diode				
I _{DR}	reverse drain current	T _{sp} = 25 °C	-	7	Α
I _{DRM}	peak reverse drain current	T_{sp} = 25 °C; pulsed; $t_p \le 10 \mu s$	-	30	Α
Avalanch	ne ruggedness				
E _{DS(AL)S}	non-repetitive drain-source avalanche energy	unclamped inductive load; I_D = 6 A; $V_{DS} \le 55$ V; R_{GS} = 50 Ω ; V_{GS} = 5 V; starting at T_j = 25 °C	-	36	mJ
E _{DS(AL)R}	repetitive drain-source avalanche energy		[1] _	-	

[1] Conditions:

- a) Maximum value not quoted. Repetitive rating defined in Figure 16.
- b) Single-pulse avalanche rating limited by $T_{j(max)}$ of 150 $^{\circ}\text{C}.$
- c) Repetitive avalanche rating limited by an average junction temperature of 145 °C.
- d) Refer to application note AN10273 for further information.



$$P_{der} = \frac{P_{tot}}{P_{tot(25^{\circ}C)}} \times 100 \%$$

Fig 1. Normalized total power dissipation as a function of solder point temperature

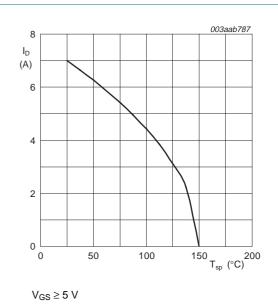
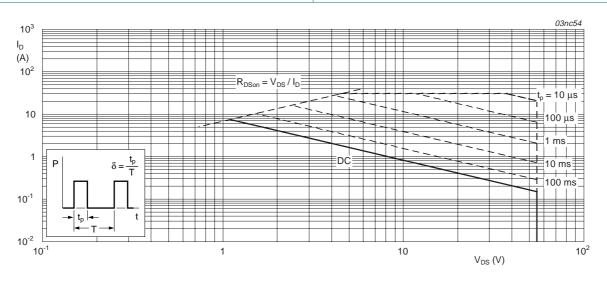


Fig 2. Continuous drain current as a function of solder point temperature



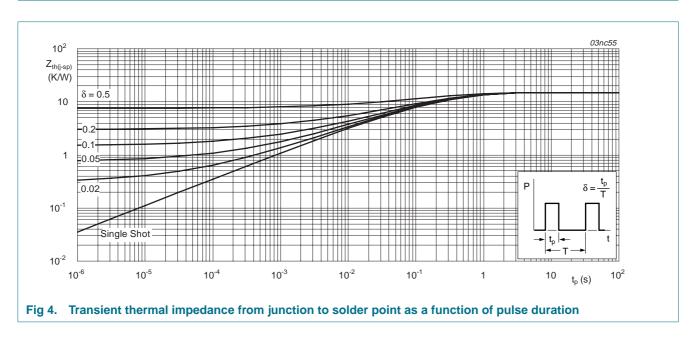
 T_{sp} = 25 °C; I_{DM} is single pulse.

Fig 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage

5. Thermal characteristics

Table 4. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$R_{th(j-a)}$	thermal resistance from junction to ambient		-	70	-	K/W
$R_{th(j-sp)}$	thermal resistance from junction to solder point		-	-	15	K/W



6. Characteristics

Table 5. Characteristics

 $T_j = 25 \,^{\circ}C$ unless otherwise specified.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static cha	aracteristics					
V _{(BR)DSS}	drain-source breakdown voltage	$I_D = 250 \mu\text{A}; V_{GS} = 0 \text{V}$				
		T _j = 25 °C	55	-	-	V
		T _j = −55 °C	50	-	-	V
V _{GS(th)}	gate-source threshold voltage	$I_D = 1 \text{ mA}$; $V_{DS} = V_{GS}$; see <u>Figure 9</u> and <u>10</u>				
		T _j = 25 °C	1	1.5	2	V
		T _j = 150 °C	0.6	-	-	V
		T _j = −55 °C	-	-	2.3	V
I _{DSS}	drain leakage current	$V_{DS} = 55 \text{ V}; V_{GS} = 0 \text{ V}$				
		T _j = 25 °C	-	0.05	10	μΑ
		T _j = 150 °C	-	-	500	μΑ
I _{GSS}	gate leakage current	$V_{GS} = \pm 10 \text{ V}; V_{DS} = 0 \text{ V}$	-	2	100	nA
R _{DSon}	drain-source on-state resistance	$V_{GS} = 5 \text{ V}$; $I_D = 8 \text{ A}$; see <u>Figure 7</u> and <u>8</u>				
		T _j = 25 °C	-	68	80	$m\Omega$
		T _j = 150 °C	-	-	147	$m\Omega$
		V _{GS} = 4.5 V; I _D = 8 A	-	-	89	$m\Omega$
		V _{GS} = 10 V; I _D = 8 A	-	62	73	$m\Omega$
Dynamic	characteristics					
Q _{G(tot)}	total gate charge	$I_D = 10 \text{ A}; V_{DD} = 44 \text{ V}; V_{GS} = 5 \text{ V};$ see Figure 14	-	11	-	nC
Q _{GS}	gate-source charge		-	1.6	-	nC
Q_{GD}	gate-drain charge		-	4.6	-	nC
C _{iss}	input capacitance	$V_{GS} = 0 \text{ V}; V_{DS} = 25 \text{ V}; f = 1 \text{ MHz};$	-	438	584	pF
C _{oss}	output capacitance	see Figure 12	-	87	104	pF
C _{rss}	reverse transfer capacitance		-	62	85	pF
t _{d(on)}	turn-on delay time	$V_{DS} = 30 \text{ V}; R_L = 1.2 \Omega;$	-	8	-	ns
t _r	rise time	V_{GS} = 5 V; R_G = 10 Ω	-	118	-	ns
t _{d(off)}	turn-off delay time		-	20	-	ns
t _f	fall time		-	32	-	ns
Source-d	rain diode					
V_{SD}	source-drain voltage	I _S = 15 A; V _{GS} = 0 V; see <u>Figure 15</u>	-	0.85	1.2	V
t _{rr}	reverse recovery time	$I_S = 20 \text{ A}; dI_S/dt = -100 \text{ A/}\mu\text{s};$	-	33	-	ns
Q _r	recovered charge	$V_{GS} = -10 \text{ V}; V_R = 30 \text{ V}$	-	60	-	nC

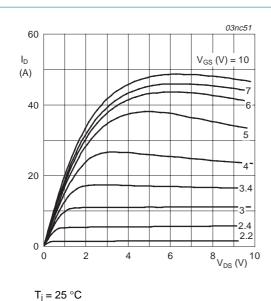


Fig 5. Output characteristics: drain current as a function of drain-source voltage; typical values

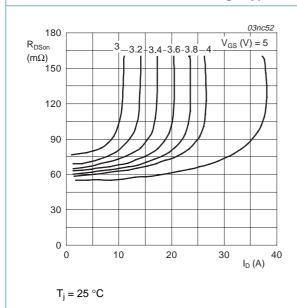
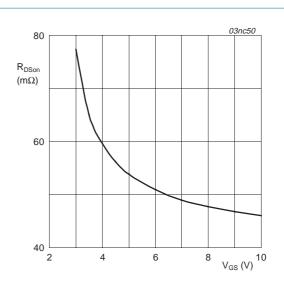
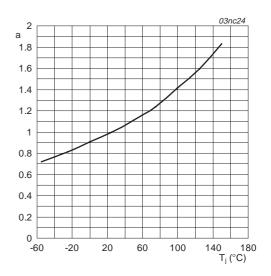


Fig 7. Drain-source on-state resistance as a function of drain current; typical values



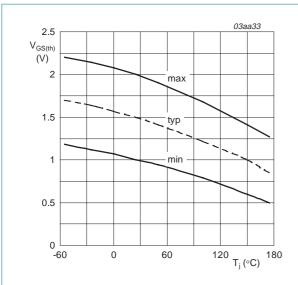
 $T_j = 25$ °C; $I_D = 10$ A

Fig 6. Drain-source on-state resistance as a function of gate-source voltage; typical values



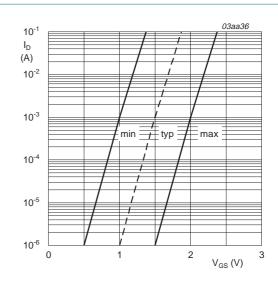
$$a = \frac{R_{DSon}}{R_{DSon(25^{\circ}C)}}$$

Fig 8. Normalized drain-source on-state resistance factor as a function of junction temperature



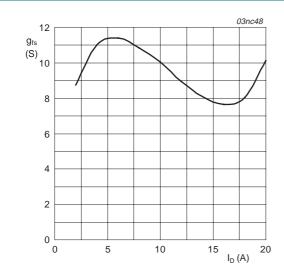
 $I_D = 1 \text{ mA}; V_{DS} = V_{GS}$

Fig 9. Gate-source threshold voltage as a function of junction temperature



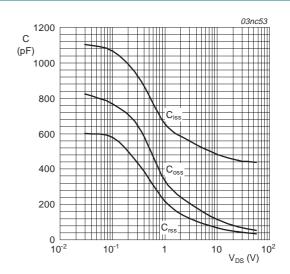
 $T_j = 25 \, ^{\circ}C; \, V_{DS} = V_{GS}$

Fig 10. Sub-threshold drain current as a function of gate-source voltage



 $T_i = 25 \,^{\circ}C; \, V_{DS} = 25 \,^{\circ}V$

Fig 11. Forward transconductance as a function of drain current; typical values



 $V_{GS} = 0 V$; f = 1 MHz

Fig 12. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values

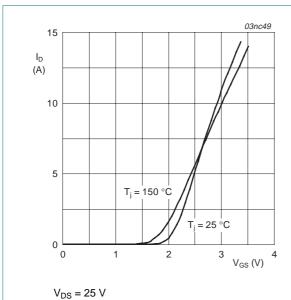


Fig 13. Transfer characteristics: drain current as a function of gate-source voltage; typical values

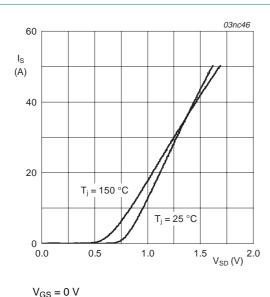
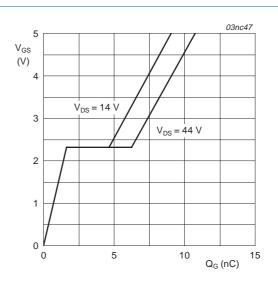
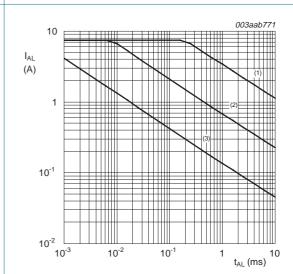


Fig 15. Source (diode forward) current as a function of source-drain (diode forward) voltage; typical values



 $T_i = 25 \,^{\circ}C; I_D = 10 \,^{\circ}A$

Fig 14. Gate-source voltage as a function of gate charge; typical values



See Table note 1 of Table 3 "Limiting values".

- (1) Single-pulse; $T_i = 25$ °C.
- (2) Single-pulse; T_i = 125 °C.
- (3) Repetitive.

Fig 16. Single-pulse and repetitive avalanche rating; avalanche current as a function of avalanche time

7. Package outline

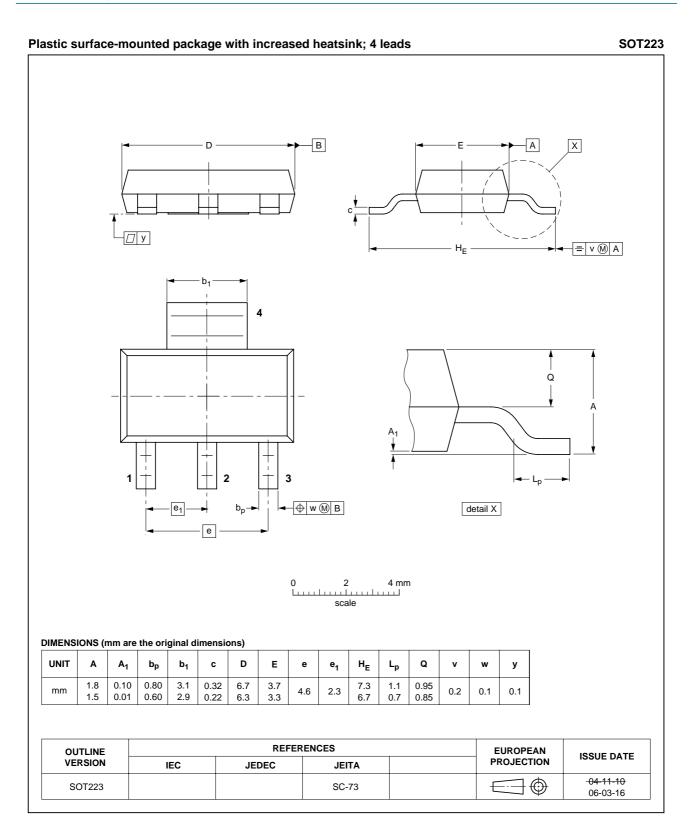


Fig 17. Package outline SOT223 (SC-73)

8. Revision history

Table 6. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes	
BUK9880-55A_2	20070412	Product data sheet	-	BUK9880_55A-01	
Modifications:	 The format of this data sheet has been redesigned to comply with the new identity guidelines of NXP Semiconductors. 				
	 Legal texts ha 	ve been adapted to the new	company name where	appropriate.	
	 Section 4 "Lim 	niting values": corrected V _{GS}	value from ±10 V to ±1	5 V.	
BUK9880_55A-01 (9397 750 07736)	20010207	Product specification	-	-	

9. Legal information

9.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions"
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BUK9880-55A

N-channel TrenchMOS logic level FET

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